

Electronic Supplementary Material (ESI) for RSC Advances.
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Fabrication of electroactive poly(vinylidene fluoride) through non-isothermal crystallization and supercritical CO₂ processing

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I. Peak to valley height ratio method

Fig. S1 visualizes the definition of ΔH_{β} and ΔH_{γ} , the height difference between the peaks at 1275 cm⁻¹ and 1234 cm⁻¹ to their nearest valleys, respectively. The wavenumbers of the valleys differ depending on the FTIR absorbance curve but they are approximately at 1260 and 1225 cm⁻¹ for ΔH_{β} and ΔH_{γ} , respectively.

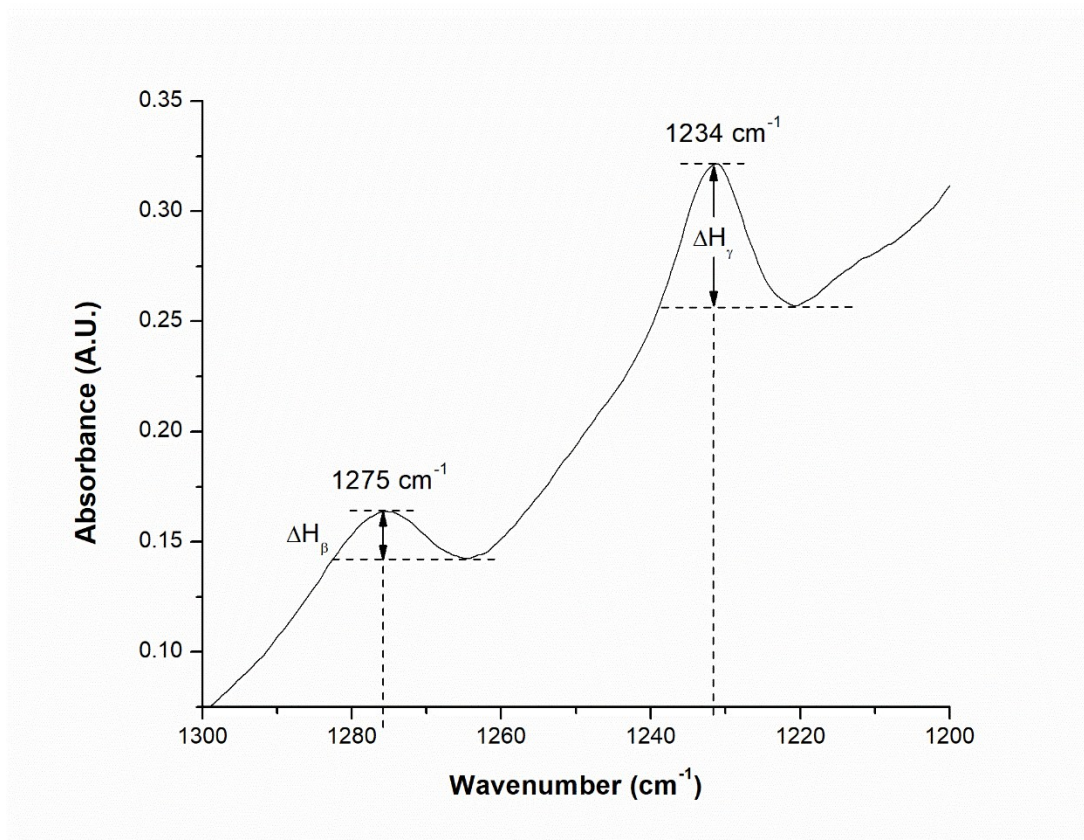


Figure S1 Visual representation of ΔH_{β} and ΔH_{γ} for the peak to valley height ratio method

II. Volume expansion ratios of samples prepared using temperature profile 1

Equations (1) and (2) were used to determine the volume expansion ratio (*VER*) of ScCO₂ processed PVDF samples. Each condition used at least three samples to calculate the average *VER* and the standard deviations. All *VER* had a standard deviation smaller than 0.55 except the samples prepared at saturation pressure and temperature at 2500 psi and 160°C, respectively, with a standard deviation of 2.57. The slightly larger standard deviation did not affect the overall trend of the relationship between the *VER* and the ScCO₂ processing conditions.

Table S1 Raw data for volume expansion ratio for temperature profile 1

Saturation Pressure (psi)	Saturation Temperature (°C)	Average <i>VER</i>	Standard Deviation
1200	100	1.02	0.01
1200	120	1.02	0.01
1200	140	1.03	0.02
1200	160	3.78	0.41
1200	180	1.26	0.08
2000	100	1.02	0.01
2000	120	1.03	0.01
2000	140	1.04	0.01
2000	160	15.35	0.52
2000	180	1.22	0.08
2500	100	1.01	0.04
2500	120	1.03	0.01
2500	140	1.08	0.01
2500	160	12.76	2.57
2500	180	1.18	0.04

III. Degree of crystallinity of samples prepared using temperature profile 1

Equation (3) was used to determine the degree of crystallinity (X_c). Each condition used at least three samples to calculate the average X_c and standard deviation. "Compression molded" are samples without undergoing non-isothermal crystallization or ScCO_2 processing. The X_c for samples prepared using temperature profile 1 had an average standard deviation of 1.35.

Table S2 Raw data for degree of crystallinity for temperature profile 1

Saturation Pressure (psi)	Saturation Temperature (°C)	Average X_c (%)	Standard Deviation (%)
Compression Molded	-	43.61	4.62
No CO ₂	100	55.51	0.97
No CO ₂	120	54.80	0.69
No CO ₂	140	51.96	1.45
No CO ₂	160	51.17	0.30
No CO ₂	180	40.61	0.93
1200	100	52.67	1.41
1200	120	54.17	1.53
1200	140	51.72	2.66
1200	160	47.85	1.75
1200	180	41.43	1.30
2000	100	48.15	1.32
2000	120	53.20	0.80
2000	140	53.49	1.08
2000	160	43.93	1.62
2000	180	40.34	1.73
2500	100	51.16	0.13
2500	120	51.68	1.17
2500	140	53.40	1.23
2500	160	46.74	0.95
2500	180	42.09	0.66

IV. Volume expansion ratios of samples prepared using temperature profile 2

This analysis was identical to the *VER* of samples prepared using temperature profile 1, using Equations (1) and (2). Each condition used at least three to calculate for the average *VER* and standard deviations.

Table S3 Raw data for volume expansion ratio for temperature profile 2

Saturation Pressure, P_{sat} (psi)	Heating Temperature, T_H (°C)	Saturation Temperature, T_{sat} (°C)	Pressure Drop Rate, $-dP/dt$ (MPa/s)	Average <i>VER</i>	Standard Deviation
2000	180	160	190.6	4.52	0.37
2000	180	160	55.2	2.73	0.19
2000	200	160	190.6	12.00	2.07

V. Degree of crystallinity of samples prepared using temperature profile 2

Table S4 Raw data for degree of crystallinity for temperature profile 2

Saturation Pressure, P_{sat} (psi)	Heating Temp., T_H (°C)	Saturation Temp., T_{sat} (°C)	Pressure Drop Rate, $-dP/dt$ (MPa/s)	Average X_C (%)	Standard Deviation (%)
No CO ₂	180	160	190.6	51.13	2.01
2000	180	160	190.6	52.40	2.02
2000	180	160	55.2	45.85	1.22
2000	200	160	190.6	54.98	2.38

VI. Scanning electron microscopy of samples prepared using temperature profile 2 for the observation of PVDF's microstructures

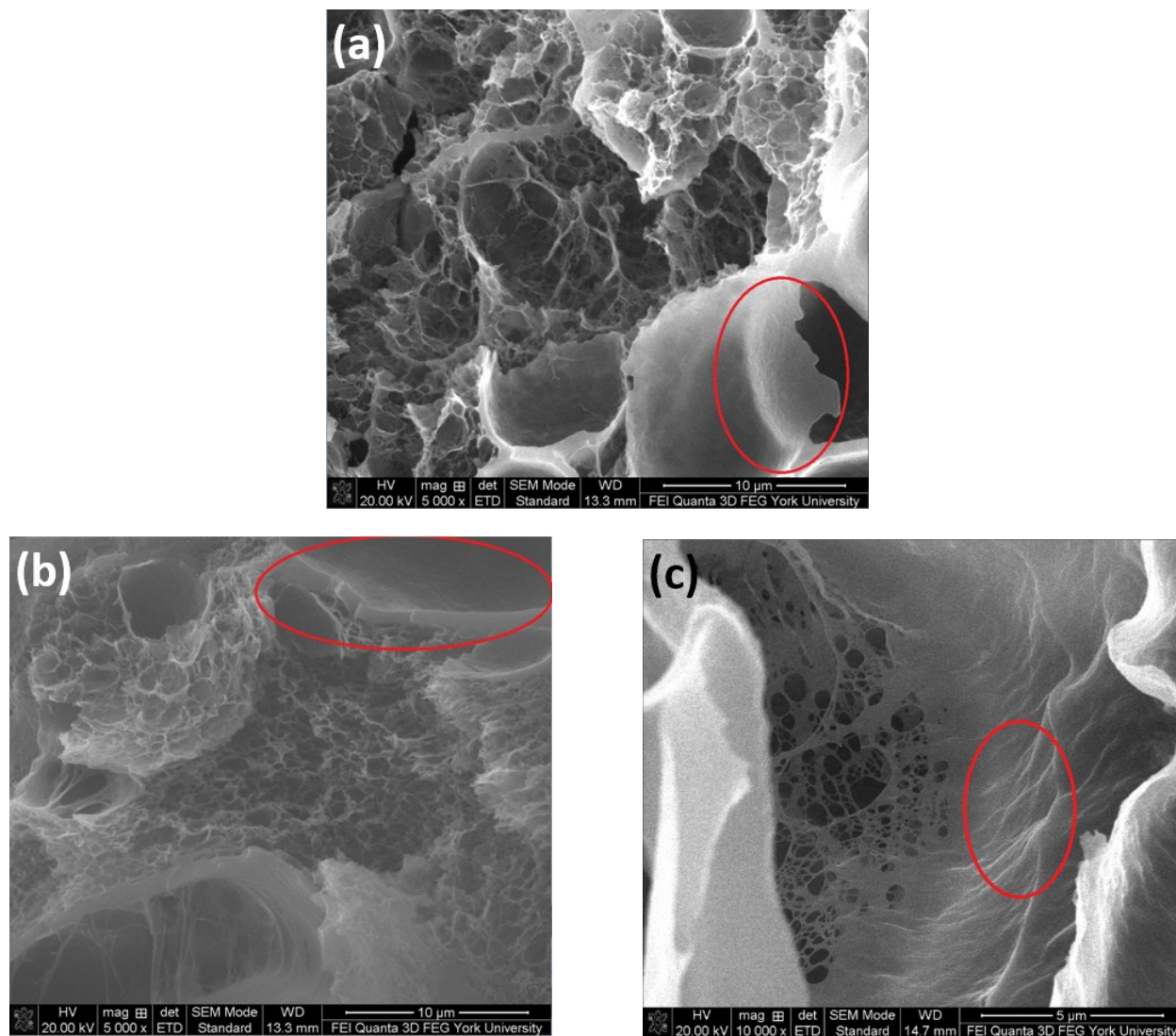


Figure S2 SEM micrographs of PVDF samples showcasing their microstructures after being processed by ScCO₂ using temperature profile 2 at 2000 psi, T_{sot} of 160°C and T_H of: (a) 180°C with $-dP/dt = 190.6$ MPa/s at 5000x; (b) 180°C with $-dP/dt = 55.2$ MPa/s at 5000x; (c) 200°C with $-dP/dt = 190.6$ MPa/s at 10 000x